

inorganicventures.com

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# CERTIFICATE OF ANALYSIS

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## 1.0 ACCREDITATION / REGISTRATION

**INORGANIC VENTURES** is accredited to ISO Guide 34, "General Requirements for the Competence of Reference Material Producers" and ISO/IEC 17025, "General Requirements for the Competence of Testing and Calibration Laboratories". Inorganic Ventures is also an ISO 9001 registered manufacturer (SAI Global File Number 010105).



#### 2.0 PRODUCT DESCRIPTION

Matrix:

Product Code: Single Analyte Mass Spec Solution

Catalog Number: MSGE-10PPM
Lot Number: J2-GE01115

tr. HNO3 tr. HF

Value / Analyte(s): 10 μg/mL ea:

Ge

Starting Material: Ge powder

Starting Material Lot#: 1636

Starting Material Purity: 99.9863%

### 3.0 CERTIFIED VALUES AND UNCERTAINTIES

Certified Value:  $10.001 \pm 0.045 \,\mu\text{g/mL}$ 

**Certified Density:** 0.998 g/mL (measured at 20  $\pm$  1 °C)

**Assay Information:** 

 ANALYTE
 METHOD
 NIST SRM#
 SRM LOT#

 Ge
 Calculated
 See Sec. 4.2

 Ge
 ICP Assay
 3120a
 080429

The following equations are used in the calculation of the certified value and the uncertainty. Reported uncertainties represent expanded uncertainties expressed at approximately the 95% confidence level using a coverage factor of k = 2.

#### Characterization of CRM/RM by Two Methods

Certified Value,  $X_{CRM/RM}$ , where two methods of characterization are used is the weighted mean of the two results:

 $\mathsf{X}_{\mathsf{CRM}/\mathsf{RM}} = [(\mathsf{w}_a)\; (\mathsf{X}_a) + (\mathsf{w}_b)\; (\mathsf{X}_b)]$ 

 $X_a$  = mean of Assay Method A with standard uncertainty  $u_{char}$  a

X<sub>b</sub> = mean of Assay Method B with standard uncertainty u<sub>char b</sub>

 $\mathbf{w_a}$  and  $\mathbf{w_b}$  = the weighting factors for each method calculated using the inverse square of the variance:

 $\mathbf{w_a} = (1/u_{\text{char a}})^2 / ((1/u_{\text{char a}})^2 + (1/u_{\text{char b}})^2))$  $\mathbf{w_b} = (1/u_{\text{char b}})^2 / ((1/u_{\text{char a}})^2 + (1/u_{\text{char b}})^2))$ 

CRM/RM Expanded Uncertainty (±) =  $U_{CRM/RM} = k (u_{char}^2 + u_{bb}^2 + u_{lts}^2 + u_{sts}^2)^{1/2}$ 

k = coverage factor = 2 in all cases at Inorganic Ventures

 $\begin{array}{l} \textbf{u}_{\textbf{char a\&b}} = [(w_a)^2 \ (u_{\textbf{char a}})^2 + (w_b)^2 \ (u_{\textbf{char b}})^2]^{1/2} \ \ \text{where } u_{\textbf{char a}} \ \ \text{and} \ \ u_{\textbf{char b}} \ \ \text{are the square} \\ \text{root of the sum of the squares of errors from characterization which include instrument} \\ \text{measurement, density, NIST SRM uncertainty, weighing, and volume} \end{array}$ 

 $\mathbf{u_{bb}}$  = bottle to bottle homogeneity standard uncertainty

ults = long term stability standard uncertainty (storage)

u<sub>sts</sub> = short term stability standard uncertainty (transportation)

## Characterization of CRM/RM by One Method

Certified Value, X<sub>CRM/RM</sub>, where one method of characterization is used is the mean of individual results:

X<sub>CRM/RM</sub> = mean of Assay Method A with standard uncertainty u<sub>char a</sub>

CRM/RM Expanded Uncertainty (±) =  $U_{CRM/RM} = k (u^2_{char} a + u^2_{bb} + u^2_{lts} + u^2_{sts})^{1/2}$ 

k = coverage factor = 2 in all cases at Inorganic Ventures

u<sub>char a</sub> = square root of the sum of the squares of the errors from characterization which include instrumental measurement, density, NIST SRM uncertainty, weighing, and volume

u<sub>bh</sub> = bottle to bottle homogeneity standard uncertainty

ults = long term stability standard uncertainty (storage)

u<sub>sts</sub> = short term stability standard uncertainty (transportation)

#### 4.0 TRACEABILITY TO NIST

- This product is traceable to NIST via an unbroken chain of comparisons. The uncertainties for each certified value are reported, taking into account the SRM/RM uncertainty error and the measurement, weighing and volume dilution errors. In rare cases where no NIST SRM/RM are available, the term 'in-house std.' is specified.

#### 4.1 Thermometer Calibration

- All thermometers are NIST traceable through thermometers that are calibrated by an accredited calibration laboratory.

#### 4.2 Balance Calibration

- All analytical balances are calibrated by an accredited calibration laboratory and procedure. The weights used for testing are annually compared to master weights and are traceable to NIST.

#### 4.3 Glassware Calibration

- An in-house procedure is used to calibrate all Class A glassware used in the manufacturing and quality control of CRM/RMs.

## 5.0 TRACE METALLIC IMPURITIES (TMI ) DETERMINED BY ICP-MS AND ICP-OES (µg/mL)

CRM/RMs are tested for trace metallic impurities by Axial ICP-OES and ICP-MS. The result from the most sensitive method for each element, is reported below. Solutions tested by ICP-MS were analyzed in an ULPA-Filtered Clean Room. An ULPA-Filter is 99.9985% efficient for the removal of particles down to 0.3 µm.

М	Ag	<	0.004591	М	Eu	<	0.006886	0	Na		0.000092	0	Se	<	0.014168	0	Zn	<	0.002361
0	Αl	<	0.007084	0	Fe		0.000154	0	Nb	<	0.002361	0	Si		0.000410	0	Zr	<	0.002597
0	As	<	0.012751	0	Ga	<	0.011807	М	Nd	<	0.004591	M	Sm	<	0.002295				
M	Au	<	0.006886	M	Gd	<	0.002295	М	Ni	<	0.018364	M	Sn	<	0.011478				
0	В	<	0.023614	s	Ge	<		n	Os	<		0	Sr	<	0.008029				
M	Ba	<	0.022956	M	Hf	<	0.004591	0	Р	<	0.006139	M	Ta		0.000199				
M	Be	<	0.001147	0	Hg	<	0.028337	М	Pb	<	0.006886	M	Tb	<	0.000688				
M	Bi	<	0.000918	M	Но	<	0.001147	0	Pd	<	0.007084	M	Te	<	0.068868				
0	Ca		0.000133	M	In		0.000399	М	Pr	<	0.000688	M	Th	<	0.002295				
M	Cd	<	0.006886	M	lr	<	0.011478	М	Pt	<	0.004591	M	Ti	<	0.114781				
M	Ce	<	0.011478	0	K	<	0.004250	М	Rb	<	0.002295	M	TI	<	0.002295				
M	Co	<	0.006886	M	La	<	0.001147	М	Re	<	0.002295	M	Tm	<	0.000918				
M	Cr	<	0.011478	0	Li	<	0.000047	М	Rh	<	0.002295	M	U	<	0.004591				
M	Cs	<	0.000688	M	Lu	<	0.000918	М	Ru	<	0.004591	M	V	<	0.004591				
0	Cu	<	0.002361	0	Mg		0.000004	0	S	<	0.059036	M	W	<	0.022956				
M	Dy	<	0.013773	M	Mn	<	0.009182	М	Sb	<	0.001147	0	Υ	<	0.002361				
M	Er	<	0.011478	М	Мо	<	0.004591	M	Sc	<	0.022956	M	Yb	<	0.002295				

M - Checked by ICP-MS O - Checked by ICP-OES i - Spectral Interference

#### 6.0 INTENDED USE

- For the calibration of analytical instruments and validation of analytical methods as appropriate.

#### 7.0 INSTRUCTIONS FOR THE CORRECT USE OF THIS REFERENCE MATERIAL

### 7.1 Storage and Handling Recommendations

- Keep cap tightly sealed when not in use. Store and use at  $20 \pm 4^{\circ}$  C. Do not pipette from the container. Do not return removed aliquots to container.

Atomic Weight; Valence; Coordination Number; Chemical Form in Solution - 72.59 +4 6 Ge(OH)x(F)y2-Chemical Compatibility - Stable in HCl, HF, H3PO4 H2SO4 and HNO3 as the Ge(OH)x(F)y2-. Avoid neutral to basic media. Unstable at ppm levels with metals that would pull F- away (i.e. Do not mix with Alkaline or Rare Earths or high levels of transition elements unless they are fluorinated). Stable with most inorganic anions with a tendency to hydrolyze.

**Stability** - 2-100 ppb levels - stability unknown alone or mixed with all other metals as the Ge(OH)x(F)y2-. 1-10,000 ppm single element solutions as the Ge(OH)x(F)y2- chemically stable for years in 2-5% HNO3 / trace HF in a LDPE container.

**Ge Containing Samples (Preparation and Solution) -** Metal (Soluble in 1:1:1 H2O / HF / HNO3); Oxide - GeO (Readily soluble in HCl or NaOH), GeO2 (fuse in Pt0with Na2CO3 followed by HCl solution of the fuseate); Geological Samples (fuse in Pt0with Na2CO3 followed by HCl solution of the fuseate); Organic Matrices (Dry ash at 450EC in Pt0 and dissolve by gently warming with 1:1:1 H2O / HF / H2SO4 or fuse ash with Na2CO3 and dissolve fuseate with HCl / H2O).

Atomic Spectroscopic Information (ICP-OES D.L.s are given as radial/axial view):

Technique/Line	Estimated D.L.	Order	Interferences (underlined indicates severe)					
ICP-MS 72 amu	20	n/a	36Ar2,37Cl17O18O,					
			37Cl35Cl,36S18O2,					
			36S2,36Ar36S,56Fe					
			16O,40Ar16O2,40C					
			a16O2,40Ar32S,144					
			Nd2+,44Sm2+					
ICP-OES 164.919 nm	0.01 / 0.001 μg/mL	1	Co, Fe, Cu					
ICP-OES 219.871 nm	0.06 / 0.009 micro;g/mL	1	W, Ir, Re, Co					
ICP-OES 265.117 nm	0.05 / 0.009 micro;g/mL	1	Ta, Pt, Mn, Rh, Ce, Nb, Hf					

HF Note: This standard should not be prepared or stored in glass.

#### 8.0 HAZARDOUS INFORMATION

- Please refer to the Safety Data Sheet for information regarding this CRM/RM.

#### 9.0 HOMOGENEITY

- This solution was mixed according to an in-house procedure and is guaranteed to be homogeneous. Homogeneity data indicate that the end user should take a minimum sample size of 0.2 mL to assure homogeneity.

## 10.0 QUALITY STANDARD DOCUMENTATION

## 10.1 10CFR50 Appendix B - Nuclear Regulatory Commission

- Domestic Licensing of Production and Utilization Facilities

## 10.2 10CFR21 - Nuclear Regulatory Commission

- Reporting defects and Non-Compliance

## 10.3 ISO 9001 Quality Management System Registration

- SAI Global File Number 010105

## 10.4 ISO/IEC Guide 17025 "General Requirements for the Competence of Testing and Calibration Laboratories"

- Chemical Testing - Accredited / A2LA Certificate Number 883.01

#### 10.5 ISO/IEC Guide 34 "General Requirements for the Competence of Reference Material Producers"

- Reference Material Producer - Accredited / A2LA Certificate Number 883.02

#### 11.0 CERTIFICATION, EXPIRATION AND PERIOD OF VALIDITY

### 11.1 Certification Issue Date

April 30, 2015

#### 11.2 Expiration Date

### 11.3 Period of Validity

- The certification is valid within the measurement uncertainty specified provided the CRM/RM is handled and stored in accordance with instructions given in Sec 7.0 and used prior to the date given in Sec 11.2. This certification is nullified if the CRM/RM is damaged, contaminated, or otherwise modified.

Zachray Saunders Burn Aleghurts Paul R. Lainea

### 12.0 NAMES AND SIGNATURES OF CERTIFYING OFFICERS

#### Certificate Prepared By:

Zach Saunders

**Product Documentation Technician** 

**Certificate Approved By:** 

Brian Alexander

PhD., Technical Process Director

**Certifying Officer:** 

Paul Gaines

PhD., Senior Technical Director

Page 4 of 4